

A maximum likelihood approach for e/p identification: application to the beam test data and simulation

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Generalities (1)

- Input variables:
 - hits in TKR bilayers h_i (i=0,17) evaluated from TkrNumStrips
 - energy deposits in CAL layers E_{j} (j=0,7) evaluated from CalXtalEne
- From a reduced sample of electrons and protons at given momentum and angle of incidence we build the probability distributions:
 - $P_i(h_i|e)$ and $P_i(h_i|p) \equiv$ probability to detect h_i hits in the i-th TKR bilayer for an electron (proton)
 - $P_j(E_j|e)$ and $P_j(E_j|p) \equiv$ probability to detect an energy release E_j in the j-th CAL layer for an electron (proton)
- For each event we evaluate the electron and proton likelihoods:

$$L_{e} = \prod_{i} P(h_{i} / e) \prod_{j} P(E_{j} / e)$$
$$L_{p} = \prod_{i} P(h_{i} / p) \prod_{j} P(E_{j} / p)$$



Generalities (2)

- Data samples:
 - 0 degrees, 10 GeV
 - runs 2338 (e) and 1419 (p)
 - 0 degrees, 20 GeV
 - runs 2082 (e) and 2232 (p)
 - 0 degrees, 100 GeV
 - runs 1980, 1981 (e) and 2362 (p)
- BT release: v7r1117p1
- Helium is taken into account in electron SPS simulated runs, but not in proton runs (some are still not available!)
- e/p identification based on the logarithmic likelihood ratio $ln(L_e/L_p)$
 - $\ln(L_e/L_p)$ > threshold value \rightarrow electron
 - − $\ln (L_e/L_p)$ < threshold value → proton
- electron identification efficiency and proton contamination change with the threshold value
- study of proton contamination vs electron efficiency

Likelihood distributions at 10 GeV/c



- The right tails of the proton distributions are originated by hadronic showers
- Data and MC exhibit a similar behaviour

Likelihood distributions at 20 GeV/c



- Same results as at 10GeV/c
- Data and MC still exhibit a similar behaviour

Likelihood distributions at 100 GeV/c



- The right tails of the proton distributions go deep inside the electron distributions
- Data and MC again exhibit a similar behaviour

Contamination vs efficiency at 10 GeV/c



Contamination vs efficiency at 20 GeV/c



Contamination vs efficiency at 100 GeV/c





Conclusions

- The maximum likelihood approach is a possible way to separate electrons from protons
 - 10 GeV/c BT data: 0.6% proton contamination at 90% electron identification efficiency
 - 20 GeV/c BT data: 2% proton contamination at 90% electron identification efficiency
 - 100 GeV/c BT data: 5% proton contamination at 90% electron identification efficiency
- A lower proton contamination can be achieved requiring a lower electron identification efficiency
- Further variables can be introduced in the likelihood to improve the particle identification performance